# In situ control of the resonant frequency of kinetic inductance detectors with multiplexed readout

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J. Appl. Phys. 138, 114502 (2025) https://doi.org/10.1063/5.0285475





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Cite as: J. Appl. Phys. 138, 114502 (2025); doi: 10.1063/5.0285475 Submitted: 15 June 2025 · Accepted: 28 August 2025 · Published Online: 15 September 2025







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### **ABSTRACT**

Large multiplexing factors are a primary advantage of kinetic inductance detectors (KIDs), but the implementation of high-density arrays still presents significant challenges. Deviations between designed and achieved resonant frequencies are common, and differential loading and responsivity variation across an array may lead to dynamic inter-resonator interactions. It is, therefore, valuable to be able to both set and maintain the resonant frequency of a KID *in situ*, using the readout system. We show that it is possible to alter the resonant frequency of the devices by more than one resonator linewidth through the application of readout current and establish a new stable operational bias point at the driven frequency by making use of the hysteretic bistability commonly seen as bifurcation in frequency-domain measurements. We examine this interaction using a readout tone at fixed frequency positioned near or within the unbiased resonant bandwidth. 🕏 Development of a control methodology based on this principle remains in an early stage, but a foundational step is understanding the interaction of the readout current with the resonator, in particular its influence on the resonant frequency. In this work, we study conventional KIDs with no physical isolation from the substrate, so we posit that the readout current primarily interacts with the resonator via nonthermal mechanisms, resulting in a predominantly reactive response. This behavior is reproduced by a simple lumped-element circuit model of the resonance and readout system, providing a straightforward framework for analysis and interpretation. This demonstration is an important early step in the development of techniques that seek to dynamically alter the resonant frequencies of conventional KID arrays and sets the stage for fast active resonant frequency control under operational conditions.

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# I. INTRODUCTION

Modern telescopes demand increasingly large and dense detector arrays and are exploring novel experiment architectures. Kinetic inductance detectors<sup>1,2</sup> (KIDs) offer high multiplexing densities and, compared with the current state-of-the-art transition edge sensor arrays, simplified fabrication and greatly reduced cryogenic hardware complexity. These attributes make them an attractive choice for these applications, with their potential extending beyond imaging arrays to more complex on-chip devices, such as filterbank spectrometers.3,4

The development of these large-scale KID arrays is not without challenges. The frequency placement of resonators along a feedline is highly sensitive to fabrication systematics and variations in material properties. This leads to scatter in the achieved vs designed resonant frequencies and, consequently, resonances that overlap with one another. Recent advances in post-fabrication tuning, such as by physically trimming the resonator capacitors, have shown that this scatter can be corrected at scale, 5-8 but this process adds complexity and lengthens the amount of time required to go from design to operational array.

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Further challenges arise during operation due to variations in responsivity and loading across resonators sharing a feedline: Certain resonators will shift in frequency more than others in response to a signal, potentially colliding with their neighbors. This may be especially problematic for a spectrometer, where adjacent detectors are more likely to experience radically different loading levels due to narrowband line emission. When collided, the two resonances and their corresponding readout tones will interfere. If one resonance moves past another, it may not be possible to reestablish which is which. Avoiding this issue typically means either deliberately lowering responsivity in the design of the sensors or reducing the resonator density in frequency space (the multiplexing factor).

The ability to adjust resonant frequencies *in situ* would provide a solution to these issues, with the potential to improve array yield and increase multiplexing density. Although primarily intended to sense changes in optical or thermal loading, KIDs also demonstrate sensitivity to low-energy photons of the readout current. This readout sensitivity is most commonly noted in the apparent distortion incurred in the resonance shape when sweeping a tone of sufficient amplitude across the resonant bandwidth. As the readout tone is swept across the resonance, the impedance it probes changes with frequency, shunting varying amounts of current through the resonance, and the resonance moves in response. Because a conventional sequential frequency sweep measurement records data at only one frequency at a time, the simultaneous motion of the resonance and readout tone complicates the view of the underlying resonator transfer function.

The strength of this sensitivity to the readout current suggests an avenue for resonant frequency control. To date, most if not all explorations of resonator current response have used either direct current or a readout tone, which is swept in frequency across the resonator bandwidth. The former typically requires a device that is purpose-built, in order to channel the current into the resonant circuit. The latter method, although broadly applicable, can obscure the effects of the readout current due to the dynamic nature of the measurement.

Recent work has demonstrated that this readout current sensitivity may be harnessed to both perturb and actively maintain the resonant frequency of a KID during changes in loading. <sup>12</sup> A system capable of stabilizing the resonators in place during operation would eliminate concerns about dynamic interactions between resonators. It also suggests the possibility of increasing the base array yield by separating resonators that are collided in their relaxed states, reducing the need for post-fabrication capacitor trimming. However, these techniques are still in the very early stages of development, requiring further study of the readout–resonator interaction.

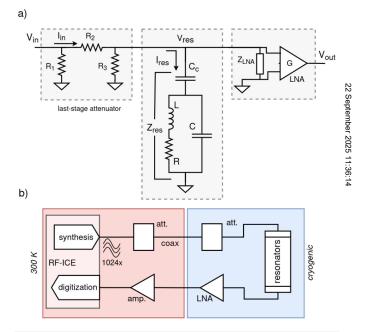
To this end, we make use of a static-frequency readout tone to inject current into the resonator and evaluate the resulting change in its resonant frequency. We build a lumped-element circuit model of the resonator, which we use to predict and analyze the impact of the readout current on the resonator. We show that we can manipulate the resonant frequency of the device over a wide bandwidth and establish a new stable bias point more than a linewidth away from the relaxed resonant frequency, and that this behavior is readily reproduced using the circuit model.

# II. CURRENT-DEPENDENT LUMPED-ELEMENT CIRCUIT MODEL

### A. Transfer function

The amount of readout current entering the resonator is determined by its impedance and the impedances of the rest of the circuit as depicted in Fig. 1(a), evaluated at the frequency of the readout tone, f. Following a standard lumped-element circuit analysis, we model the resonator as an inductance,  $L = L_k + L_g$  (with  $L_k$  and  $L_g$  being the kinetic and geometric components, respectively), and a small series real impedance R arising from the real component of the complex conductance, in parallel with a capacitor, C,

$$Z_{RLC} = \left[ (j2\pi f L + R)^{-1} + \left( \frac{1}{j2\pi f C} \right)^{-1} \right]^{-1}, \tag{1}$$



**FIG. 1.** (a) Circuit model of a single lumped element KID and surrounding readout electronics. Modeling the resonator in this simple circuit framework facilitates the study of the impact of readout current on its parameters, including predicting the current-dependent resonant frequency. All input and output voltages in this work are referred to points  $V_{in}$  and  $V_{out}$  shown in this schematic, respectively, unless otherwise noted. (b) Diagram of the measurement setup. The RF-ICE<sup>13</sup> readout platform provides up to 1024 sinusoidal readout tones, whose amplitudes and frequencies can be independently and dynamically updated. These are transported by coaxial cables through several attenuation stages to the resonator array, located within a BlueFors LD250S dilution refrigerator. The amplitude of the returning signals is conditioned by a cryogenic low-noise amplifier (LNA) and one or more stages of warm amplification, before being digitized by the RF-ICE hardware.

all of which is in series with a coupling capacitance,  $C_c$ , such that the total resonant branch has impedance

$$Z_{res} = \frac{1}{j2\pi f C_c} + Z_{RLC}.$$
 (2)

The resonator is in parallel with the input impedance of the cryogenic low-noise amplifier,  $Z_{LNA}$ , and the resistance,  $R_3$ , of the last-stage attenuator. This parallel network forms the load on the last-stage attenuator. Approximating that the voltage at point  $V_{in}$  is fixed, the transfer function for this system from this point to the output of the LNA is

$$V_{out} = V_{res}G_{LNA} = V_{in}\frac{Z_{\parallel}}{Z_{\parallel} + R_2}G_{LNA},$$
 (3)

with  $Z_{\parallel}$  being the total impedance of the parallel network including the resonator ( $Z_{res}$ ,  $Z_{LNA}$ ,  $R_3$ , and any other resonators with resonant frequencies near to that of the device of interest, not included in the system diagram in Fig. 1).

The readout current flowing through the resonator may be calculated using a current divider,

$$I_{res} = I_{in} \frac{Z_{\parallel}}{Z_{res}}, \tag{4}$$

with the input current to the network  $I_{in} = V_{in}/(Z_{\parallel} + R_2)$ .

From this, we obtain the current flowing through the inductor,  $I_L$ , as

$$I_L = I_{res} \frac{Z_{RLC}}{j2\pi fL + R}.$$
 (5)

# 1. Zero-current impedance

When no current flows through the resonator, the zero-current kinetic inductance,  $L_k(0)$ , is derived from the geometry and material properties of the superconductor, via the dirty limit surface impedance,  $^{14,15}$ 

$$Z_s = \sqrt{\frac{j2\pi f\mu_0}{\sigma}} \left( \tanh(t\sqrt{j2\pi f\mu_0\sigma}) \right)^{-1}, \tag{6}$$

where t is the thickness of the superconductor,  $\mu_0$  the permittivity of the material, and f is the frequency at which the impedance is evaluated. The complex conductivity,  $\sigma = \sigma_1 + j\sigma_2$ , of the superconductor under a given set of loading conditions is given by  $^{16}$ 

$$\sigma_1 = \sigma_N \frac{2\Delta_0}{hf} \frac{n_{qp}}{N_0 \sqrt{2\pi k_B T \Delta_0}} K_0(\xi) \tag{7}$$

and

$$\sigma_2 = \sigma_N \frac{\pi \Delta_0}{hf} \left[ 1 - \frac{n_{qp}}{2N_0 \Delta_0} \left( 1 + \sqrt{\frac{2\Delta_0}{\pi k_B T}} e^{-\xi} I_0(\xi) \right) \right], \tag{8}$$

where  $\sigma_N$  is the normal-state conductivity for the sample,  $I_0$  and  $K_0$  are modified zeroth-order Bessel functions of the first and

second kind, respectively,  $\xi = \frac{hf}{2k_BT}$ ,  $\Delta_0$  is the zero-temperature gap energy, h is the Planck constant,  $N_0$  is the single spin density of states for the sample material (here, aluminum), and  $k_B$  is the Boltzmann constant. The quasiparticle density,  $n_{qp}$ , is determined by the thermal and optical load on the detector, and for simplicity, we assume that it is unaffected by the readout current (see also Sec. IV A).

With l and w being the length and width of the inductor, we obtain values for the resistance and zero-current kinetic inductance as

$$R = \operatorname{Re}(Z_s) \frac{l}{w}$$
 and  $L_k(0) = \frac{\operatorname{Im}(Z_s)}{2\pi f} \frac{l}{w}$ , (9)

and we assume that, by design, the other component values in the circuit  $(C, L_g, C_c)$  do not vary with absorbed energy of any kind.

The detector's resonant frequency is the frequency at which  $Z_{res}$  is minimized and its imaginary component is zero. This frequency can generally be solved analytically as a function of all four lumped elements in the resonant circuit and follows the trend  $f_r \sim \sqrt{L(C+C_c)}^{-1}$ .

### 2. Current-dependent inductance

This work seeks primarily to demonstrate the use of readout current to manipulate the resonant frequency of a kinetic inductance detector. For simplicity, we consider only the reactive component of the resonator's response to readout current. The validity of Reglecting the dissipative response is touched upon in Sec. IV A. The resonator's reactive response arises from the well-documented  $I^2$  nonlinearity, which describes a current-dependent kinetic inductance of the following form:

$$L_k(I_L) \simeq L_k(0) \left(1 + \frac{|I_L|^2}{I_*^2}\right),$$
 (10)

where  $I_L$  is the readout current flowing through the inductor and  $I_*$  sets the scale of the effect. <sup>17,18</sup>

For a readout tone of amplitude  $V_{in}$  at a given frequency  $f_{drive}$  near a resonance, Eqs. (4) and (5) are now implicit expressions for the current flowing through (and therefore the impedance of) the resonator. They can be solved by beginning with the zero-current value for  $Z_{res}(f_{drive})$  and iteratively evaluating the expression for  $I_L$ , using the value obtained after each iteration to update  $L_k(I_L)$ . Proceeding in this manner, the system rapidly converges to stable values, representing the equilibrated impedance and current of the resonator for the given input. Once this is obtained, we compute the transfer function of the resonator as usual using Eq. (3), with  $Z_{res}$  now including the modification due to the current.

We fit Eq. (3) to a measurement of a resonator's transfer function at low readout amplitude across its bandwidth to extract the circuit component values, which cannot be obtained from the complex conductivity and inductor geometry. Combined with measurements of the gains and attenuations of the rest of the analog electronic system, we may then compute various aspects of the resonator's response and transfer function, under the given loading and readout frequency drive conditions. Figure 2 shows a comparison between the calculated and

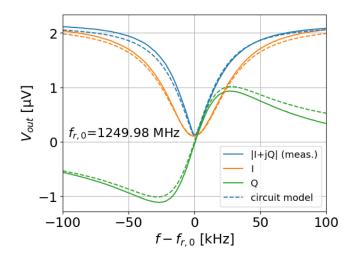


FIG. 2. Comparison of measured (at the input to the digitizer) complex output voltage for an example resonance (solid lines) vs the calculated output voltage (dashed lines) obtained using a circuit model based on this resonance. The model contains no stray impedances, resulting in an imperfect but sufficient agreement between the two. For consistency, this example resonance and circuit model are used in all figures throughout this work. The values of the circuit components, as well as the other parameters used for the resonator model (thermal and optical loading, inductor geometry, etc.), may be found in Table I in Appendix. The I and Q voltages are by definition orthogonal to each other, but the global orientation of the IQ plane is arbitrary. Here, the data have been rotated about the origin so that the derivative of Q is maximized at the resonant frequency, for the purposes of consistent visualization. These complex voltages can be related to the phase within the resonance bandwidth by fitting a circle to the data on the IQ plane and shifting the data so that the resonance circle is centered on the origin (such as described in, for example, Appendix E of Ref. 16).

measured transfer function for an example resonator. The circuit model only considers the elements featured in Fig. 1 and does not capture the effects of stray impedances which may be present in the physical system. As seen in Fig. 2, this results in an agreement between the two that will be sufficient in this context as a tool in understanding the overall behavior of the circuit.

A value for the scaling current,  $I_*$ , may be estimated by comparing the measured and predicted frequency shifts of a resonator in response to injected readout current. This method suffers from a challenge in separating the value of I\* from the amplitude of the readout current reaching the resonator, which is difficult to measure precisely due to the many temperature- and geometrydependent impedances in the system. Nonetheless, the resultant circuit model reproduces the observed behavior with sufficient accuracy to usefully predict and examine many aspects of the readout-resonator interaction. For the resonators studied in this work, we find that values of I<sub>\*</sub> in the range of 1.5-2.5 mA closely reproduce the measured behavior.

# III. MEASUREMENT SETUP

A variety of lumped-element microwave kinetic inductance detectors were studied in the development of this work. 19-21

devices have aluminum inductors and niobium capacitors (both interdigitated and parallel plate). They are designed to be either direct absorbing or to be part of an on-chip filterbank spectrometer. Their designs, fabrication procedures, and resonator properties vary widely. These devices were created as prototypes for future experiments on the South Pole Telescope<sup>4,22</sup> and were used here for the purposes of investigating the interaction of the readout current with the resonators. For consistency, all measurements shown in this work were made using a single resonator, arbitrarily selected from a prototype wafer containing 12 resonances of the style described in Ref. 19. This resonator is representative of the others on this wafer, and the results and analysis in this work were found to be generally applicable to the other device types tested.

Measurements are made using RF-ICE, a multi-tone readout platform using polyphase filterbank synthesis and demodulation to operate up to 1024 sinusoidal carrier tones per readout line.<sup>13</sup>, The resonators are cryogenically cooled to between 25 and 200 mK using a BlueFors LD250S dilution refrigerator. The resonators are mounted inside a dark aluminum sample box. The carrier comb is transmitted via coaxial cable from the synthesizer through approximately 50 dB of attenuation before the resonators, amplified by a cryogenic low-noise amplifier<sup>24</sup> (LNA) after leaving the resonators, with additional stages of room-temperature amplification added as needed. A diagram of the measurement setup may be found in Fig. 1(b).

## IV. RESPONSE TO READOUT DRIVE

This work aims to develop a practical understanding of the gonse of a KID when driven with readout current, to enable response of a KID when driven with readout current, to enable control over the KID's resonant frequency using a fixed-frequency readout drive tone. To achieve this, we first need to parametrize how the resonant frequency varies as a function of the applied drive amplitude and the frequency at which it is applied. Understanding these relations will allow us to determine the state of the KID as the readout current adjusts its resonant frequency, for the purposes of bringing it to a new operational bias point.

We reconstruct the resonance shape under a strong readout drive using multiple complementary methods. Given that the readout tone is providing the drive current with which we intend to alter the resonator's kinetic inductance, it is clear that sweeping that same readout tone in frequency across the resonant bandwidth will have marked effects on the system. The motion of the tone will be combined with the motion of the resonance in response to the tone, producing a complicated picture of a distorted resonance shape. This is generally referred to as resonance bifurcation.

The dynamic nature of this type of measurement makes it challenging to discern the complete transfer function of the resonance. To disentangle the relevant effects, we instead place a tone at a fixed frequency and vary its amplitude. This has two advantages: With the readout tone frequency now kept constant, only the motion of the resonance will be observed. Secondarily, this measurement technique mimics the intended control architecture, where we intend to operate and manipulate the resonant frequency of the detector using a fixed-frequency drive.

In the RF-ICE system, the programming of each carrier tone in the readout comb is fully independent in amplitude and

frequency and can be dynamically altered with negligible (sub-ms) latency. This allows a high degree of flexibility in the design of measurement algorithms. As we vary the fixed-frequency drive tone amplitude, we monitor the state of the resonance in one of two ways. One method uses multifrequency snapshot measurements as introduced in Ref. 12, which employ small-amplitude auxiliary readout tones to instantaneously measure the driven resonator's transfer function at an arbitrary number of frequency points across the bandwidth. The auxiliary tones are kept small enough that the power they deposit on the resonance is negligible compared to that deposited by the primary drive tone. This technique is straightforward to achieve with a multitone readout system, but an alternative measurement not requiring such a system could take the form of a single small auxiliary tone (such as from a VNA or standard homodyne system) being swept sequentially in frequency while the drive tone (contributed by a separate function generator) remains fixed.

The multifrequency measurements provide an easy visualization of the resonance's location under a given set of readout drive conditions. The use of this technique is complicated, however, by the onset of kinetic inductance parametric amplification, for which the  $I^2$  nonlinearity is also the mechanism. When the readout drive tone is within the resonance bandwidth and at sufficient amplitude, the small auxiliary tones used to probe the resonance experience parametric gain, as noted in this context in Fig. 3 of Ref. 12. Once this amplification becomes dominant, the auxiliary tones used in the multifrequency measurement no longer probe the resonator's transfer function as a direct function of its impedance. The drive tone itself is not subject to the parametric gain and (to a good approximation at moderate input powers) remains directly sensitive to the impedance of the resonator. Therefore, when the drive conditions are such that the parametric amplification is non-negligible, we revert to the second measurement option: relying on measurements from the drive tone itself in interpreting the results of the drive amplitude sweep.

In a drive amplitude sweep, as the drive tone amplitude is varied, the response of the resonator results in a changing impedance at the drive tone frequency. Measuring this impedance, and comparing it with the impedance measured as a function of frequency obtained through a readout tone frequency sweep across the same resonance at low amplitude, we can infer the location of the resonance at each point in the amplitude sweep. Sweeping the drive amplitude from low to high or high to low over a sufficient range of amplitudes, the motion of the resonance past the tone is such that the measurement traverses the entire bandwidth. Placing the drive tone at a range of offset frequencies from the unperturbed resonant frequency results in different amounts of readout current flowing through the resonance, for the same range of applied drive voltages. This is analogous to performing frequency sweeps across the resonance at a range of readout amplitudes. As seen in frequency sweeps, there is a region of this parameter space in which the response of the resonator is single-valued: An ascending sweep produces the same result as a descending sweep. Outside of this region, the resonator exhibits bistability, with a strong hysteresis on the direction of the sweep.

Figure 3 compares frequency and amplitude sweeps applied to the same resonator. The frequency sweep measurement (upper

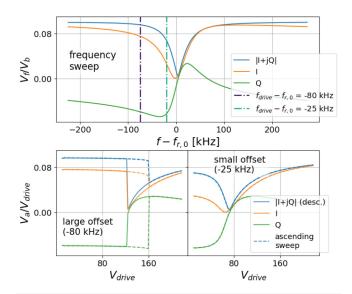


FIG. 3. Comparison of constant-amplitude frequency sweep and fixed-frequency drive amplitude sweep measurements for the same resonator. Top: lowamplitude sequential frequency sweep across the resonator, showing measured complex voltages normalized by input voltage,  $V_f/V_b$  (magnitude blue, I orange, Q green), as a function of readout tone frequency, f. Vertical dotted-dashed lines indicate the drive tone frequencies for the two amplitude sweep measurements, which are shown below. Lower panels: (left) amplitude sweep measurement with drive tone at a large offset (-80 kHz) from the relaxed resonant frequency,  $f_{r,0}$ ; (right) amplitude sweep measurement with drive tone at a small offset (-25 kHz) from  $f_{r,0}$ . Each measured output voltage,  $V_a$ , is normalized by the input voltage, V<sub>drive</sub>, at which it was obtained. When the drive tone is initialized near to the relaxed resonant frequency as in the small offset case, the system remains in the single-valued limit where the upward and downward amplitude sweeps (here shown overlaid) are identical. When it is initialized further from  $f_{r,0}$ , a directional hysteresis is evident. In all panels, dashed lines indicate an ascending sweep direction (in either frequency or amplitude), and solid lines indicate a descending sweep. The two directions are only distinguishable in the -80 kHz offset amplitude sweep.

panel) is performed with a very low amplitude readout tone so as to not perturb the resonance. The two amplitude sweeps (lower panels) span the same range of amplitudes but place the readout tone at different locations in frequency space (indicated by vertical lines superimposed on the top panel) relative to the starting location of the resonance. As can be seen in the lower panels of Fig. 3, this leads to markedly different effects on the resonance.

According to Eq. (10), an increase in the current through the resonance will increase the kinetic inductance of the resonator and decrease its resonant frequency. If the readout tone that is supplying the current (the drive tone) is located lower in frequency than the undriven (relaxed) resonant frequency (i.e.,  $f_{drive} < f_{r,0}$ ), there is a positive feedback mechanism between the increase in drive amplitude and the resonant frequency, as the impedance at the drive frequency decreases as the resonance approaches the tone, which, in turn, increases the current through the resonance when driven with a fixed-amplitude drive voltage. This will enhance the impact of a drive amplitude increase and, for large drive amplitudes, results in

the same runaway feedback effect and strong directional hysteresis that causes the canonical bifurcation behavior seen in frequency sweep measurements. Conversely, for a drive tone placed above the resonant frequency ( $f_{drive} > f_{r,0}$ ), negative feedback results from the increasing resonator impedance at the drive frequency as the resonance shifts to lower frequency, further from the tone.

By combining amplitude sweeps and multifrequency snapshot measurements, in this section, we examine the resonator's response within the single-valued and bistable regimes and explore the behavior of the resonant frequency as a function of the frequency and amplitude of the applied readout drive.

# A. Mapping between sweeps in amplitude and frequency

When the drive tone is within the resonance bandwidth, parametric amplification is commonly observed for moderate and large drive amplitudes. This prevents the use of multifrequency snapshot measurements to directly capture the resonance's response to a drive amplitude sweep in these cases. Instead, we can infer the location of the resonance using the measured return voltages  $V_a(V_{drive})$ of the drive channel, and the voltages  $V_f(f)$  gathered during a lowamplitude frequency sweep across the same resonator. Because both are a measure of the total circuit impedance, recorded complex voltages from the drive channel at each applied drive amplitude can be related to the complex voltages measured as a function of frequency during the frequency sweep, when both have been normalized by the drive amplitude at which they were obtained. By minimizing the Euclidean distance between each point in the amplitude sweep and the reference frequency sweep values, we can estimate the frequency distance between the drive tone and the resonant frequency. Said differently, for each amplitude sweep value  $V_a(V_{drive})/V_{drive}$ , we want to find the frequency f that minimizes the expression

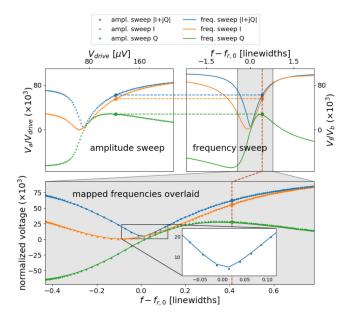
$$\left| \frac{V_f(f)}{V_b} - \frac{V_a(V_{drive})}{V_{drive}} \right|,\tag{11}$$

where we refer to the constant input amplitude of the readout tone used in the frequency sweep as  $V_b$ , for clarity in distinguishing it from the variable drive amplitude used in the amplitude sweep, which we call  $V_{drive}$ .

Figure 4 illustrates this procedure for the  $-25\,\mathrm{kHz}$  offset amplitude sweep measurement shown in the bottom right panel of Fig. 3. Each measured complex voltage  $V_a(V_{drive})/V_{drive}$  (Fig. 4, top left) is mapped to a measured complex value  $V_f(f)/V_b$  from the frequency sweep (Fig. 4, top right), by minimizing Eq. (11). In the lower panel, the amplitude sweep values (dots) are plotted at their mapped frequencies,  $V_a(f)/V_{drive}$ , and overlaid with the frequency sweep data (solid lines). Once the corresponding frequency f for each  $V_a$  has been identified, the resonant frequency,  $f_r$ , at this drive amplitude may be computed as

$$f_r|_{V_{drive}} = f_{drive} - (f - f_{r,0}).$$
 (12)

Overlaying the measured values from the frequency sweep with those obtained from the amplitude sweep, at the extracted



**FIG. 4.** Determining the corresponding frequency within the resonance bandwidth for each measured voltage value of an amplitude sweep. Complex voltage values measured during the amplitude sweep are mapped to those obtained during a frequency sweep at low amplitude, by minimizing Eq. (11). Overlaying the measured values from the amplitude sweep at their corresponding frequency locations within the frequency sweep (central panel; dots superimposed on solid lines), we see that the shape of the resonance remains largely unchanged, with the exception of the region  $|f-f_r| \le 0.1$  linewidths, wherein the depth of the resonance is seen to increase relative to its undriven shape by a small amount (inset). We, therefore, consider the effect of the readout current on the resonance to be primarily reactive.

frequency location within the resonance bandwidth (main panel of Fig. 4), shows that, aside from a small increase in resonance depth when the resonant frequency is very close to the drive frequency, there is very little divergence between the two. This region is highlighted in the inset of the lower panel of Fig. 4. This indicates that, over most of its bandwidth, although the resonator's impedance is changing as its inductance is modulated by the current, the overall shape of the transfer function remains largely unaffected, and the effect of the readout current on the resonator in this manner is primarily reactive. For simplicity in understanding the effects of readout current on resonant frequency within the scope of this work, we ignore the dissipative effects for the remainder of this work.

# B. Resonator response in the single-valued regime

When  $V_{drive}$  remains sufficiently small throughout an amplitude sweep, the response of the resonator is identical through both an increasing and decreasing sweep. In this single-valued regime, for a fixed-frequency drive tone with a given starting voltage amplitude, the amplitude of the current through the resonator is entirely determined by the location of the drive tone relative to the relaxed resonant frequency. The single-valued regime is therefore defined

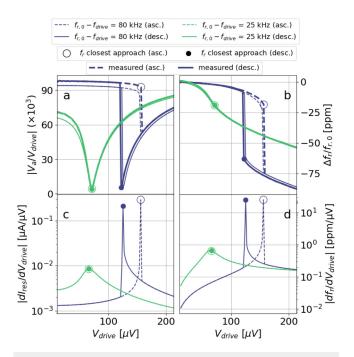
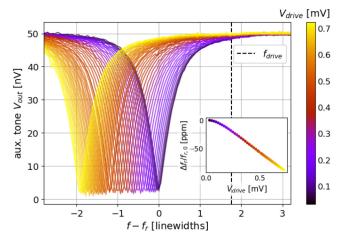


FIG. 5. Comparison and analysis of amplitude sweeps in the single-valued (green; starting offset -25 kHz) and bistable (blue; starting offset -80 kHz) regimes. Measured values are plotted in heavy lines, with thinner traces showing values computed using the circuit model as shown in Fig. 2. Solid lines indicate a descending sweep direction, while dashed lines indicate an ascending sweep. Dots indicate the last stable point in each sweep before the resonant frequency passes the drive tone, with an open circle indicating this point on the ascending sweep and a closed circle for the descending sweep. In the singlevalued regime, these points are the same in both directions and are at the driven resonant frequency itself. In the  $-80 \, \mathrm{kHz}$  sweep, the resonant frequency never reaches the drive tone, as runaway feedback causes the resonance to jump past the tone in each direction. (a) Output voltage at the drive tone frequency, normalized by input drive voltage. (b) Fractional change in driven resonant frequency vs relaxed resonant frequency. Here, the measured traces are obtained by mapping the measured voltages to the unperturbed resonance shape [Eqs. (11) and (12)]. (c) Rate of change of current through the inductor, with respect to change in the applied drive voltage. (d) Rate of change in driven resonant frequency, with respect to applied drive voltage. For both derivatives, in the  $-25 \, \text{kHz}$  offset sweep (the single-valued regime), the maximum occurs at the resonant frequency. For the  $-80\,\mathrm{kHz}$  offset sweep, the derivatives go to infinity before the resonant frequency reaches the drive tone, and the resonance jumps past the tone.

by a region in frequency space near to or above the relaxed resonance.

The green traces in Fig. 5 examine the amplitude sweep measurement depicted in the lower right panel of Fig. 3, which shows the resonator's single-valued response to a drive tone placed at a small offset (25 kHz below) from the relaxed resonant frequency. From the measurement (thick lines), we obtain the output voltage and the change in resonant frequency [Figs. 5(a) and 5(b), respectively]. Using the circuit model, we can compute the associated evolution of the rates of change in the inductor current [Fig. 5(c)] and the resonant frequency [Fig. 5(d)] with respect to the applied



**FIG. 6.** Amplitude sweep for a drive tone at fixed frequency 100 kHz (approximately 2 linewidths; position indicated by dashed black line) above the relaxed resonant frequency. The transfer function of the resonance is measured at each applied drive amplitude using multifrequency snapshot measurements (colored traces). As the drive tone amplitude is increased, the resonance shifts to lower frequency, at a rate that is approximately linear in the applied amplitude.

drive amplitude. As the drive amplitude is increased, the resonance moves toward the tone, reaching a new stable equilibrium resonant frequency at each input amplitude value, until eventually the resonant frequency moves smoothly past the drive tone and continues on to lower frequency. When the resonant frequency is above the drive tone, the impedance at the drive frequency decreases as the resonance moves toward the drive tone. Correspondingly, the rate of change in the current through the inductor increases with increasing proximity to the drive tone, as does the rate of change in the resonant frequency. This is a positive feedback regime.

When the resonant frequency is below the drive tone, the system enters the negative feedback regime: An increase in the drive amplitude results in an increase in the frequency distance between the resonance and the drive tone, which increases the impedance at the drive frequency and reduces the current flowing through the resonant branch (and thereby through the inductor). Although the impedance at the drive frequency quickly becomes large because the applied drive voltage amplitude is steadily increased, the current through the resonance continues to increase as well due to the increase in applied drive voltage. In this regime, the rate of change in the resonant frequency approaches a constant value, as can be seen at the higher drive amplitudes in Fig. 5(d).

A more striking demonstration of this effect is shown in Fig. 6, where an amplitude sweep is performed with the drive tone initialized 100 kHz above the relaxed resonant frequency. Here, we use multifrequency measurements (colored traces) to directly capture the resonance transfer function as the drive amplitude is increased and observe the approximately linear trend in the resonant frequency shift as a function of drive amplitude.

Proceeding in this manner, the resonance can be driven to a substantial frequency offset. The distance over which it may be driven is constrained by the linearity threshold of the LNA, which limits the allowed drive amplitude, and by current leakage through other resonators in the array. The nearest frequency neighbor to the resonance shown in Fig. 6 is roughly 2 MHz above its relaxed resonant frequency. When the target resonance has been driven away from the drive tone, a non-negligible fraction of the drive current will begin to flow through this neighboring resonance. This increases its kinetic inductance, decreases its resonant frequency, and will eventually draw it in toward the drive tone, disrupting the further driving of the target resonance. In a more densely packed array, the nearest frequency neighbors may be expected to be closer. This drive tone leakage limits the extent of the amplitude that may be applied, unless the target is sufficiently isolated from its neighbors.

We now consider the utility of this technique as an operational mode. Typical readout of kinetic inductance detectors uses a single readout tone to monitor the location of the resonance in frequency space as it is modulated by absorbed light or thermal energy. The sensitivity of the readout tone to changes in the resonance falls as a function of the separation of the readout tone from the resonant frequency. Therefore, generally speaking, the further the resonance is driven from the drive tone, the less sensitive the drive tone is to changes in loading on the resonance. A second tone could be used to monitor the resonance in its new driven location, although this comes at the cost of increasing readout complexity.

However, if the drive tone is located below rather than above the relaxed resonant frequency, the readout amplitude may be sufficiently increased to bring the driven resonant frequency to align with the tone. At this point, the detector may be read out as usual, using a readout tone that is fixed in both amplitude and frequency. To the limit of not exceeding the linear dynamic range of the LNA, the resonant frequency of an arbitrary number of detectors in the array may be tuned in this fashion. Each resonant frequency may therefore be brought to the readout tone, rather than the readout needing to follow the resonance. This allows the use of integermultiple frequency scheduling for intermodulation distortion mitigation, without sacrificing sensitivity due to detuning between the readout and resonant frequencies. Furthermore, the use of larger readout amplitudes increases the ratio of the signal above the LNA noise, relaxing hardware constraints.

The ability to adjust the resonant frequencies in this way suggests using this technique to separate resonators that are collided in their relaxed state. If two resonators have nearly identical resonant frequencies, the readout current will be split nearly evenly between them, and they will experience nearly identical frequency shifts. For larger separations, the difference in the resonators' impedance at the drive frequency is larger, and so the readout current will preferentially shift the resonant frequency of one more than the other, increasing the frequency distance between them. More work is needed to explore the use of this technique and its implications for device operability and array yield.

# C. Resonator response in the bistable regime

In the single-valued regime, for a given drive tone frequency at a given amplitude, there is a unique solution to the resonator impedance and resonant frequency. This single-valued response occurs for a range of drive tone frequencies that are near to or

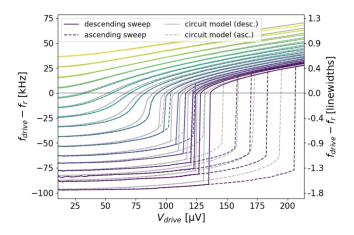


FIG. 7. Resonant frequency as a function of readout drive amplitude (referred to the  $V_{in}$  point in Fig. 1) for amplitude sweeps taken over a range of starting drive frequency offsets from the relaxed resonant frequency. The colored traces are measurements, with the color of the trace corresponding to the starting frequency offset between the drive tone and the relaxed resonant frequency. Gray traces show the same quantity, computed using the circuit model based on this resonance. For sweeps beginning with the drive tone below the relaxed resonant frequency, the resonance exhibits bistability for initial drive frequency offsets  $f_{drive} - f_{r,0} \lesssim -50$  kHz. For sweeps beginning nearer to (small values of  $|f_{drive} - f_{r,0}|$ ) or above the relaxed resonant frequency, the response is singlevalued. Although on the ascending sweep, in the bistable region, the separation between the driven resonant frequency  $f_r$  and the drive tone remains large, once the resonance has jumped to the second bistable state,  $f_r$  may be approached from the other direction, by reducing  $V_{\textit{drive}}$ . Any trace that has a stable point at or very near to the zero-crossing may be considered a viable operational bias point for the resonator. On the descending branch, such bias points may be achieved up to very large initial frequency offsets.

above the relaxed resonant frequency. Outside this region (blue traces in Fig. 5), for increasing amplitude sweeps with drive tone frequencies below  $f_{r,0}$ , runaway positive feedback prevents the resonant frequency from ever stably reaching the drive tone. Instead, the resonance jumps past the tone, to a new stable state at lower frequency. This is the same instability that is seen as bifurcation in frequency sweeps at large constant amplitude (Refs. 10 and 11, among others). In the frequency sweep context, the two branches of the bifurcated resonance state can be accessed by sweeping either upward or downward in frequency. Analogously, in an amplitude sweep, the second resonator state can be accessed by decreasing the amplitude of an initially large drive tone. Unlike the single-valued regime, this is a region in the *offset frequency-drive amplitude* parameter space where there are two physical solutions for the impedance and resonant frequency of a resonator, with each accessible through a hysteresis of the drive amplitude.

This frequency–amplitude space is mapped out for an example resonator in Fig. 7. The drive tone is initialized at low amplitude at a range of offset frequencies from  $f_{r,0}$ . As its amplitude is increased over a range spanning approximately a factor of 20 in voltage, the measured voltage at  $f_{drive}$  is recorded and used to determine the relative location of the driven resonant frequency,  $f_r$ , at each input amplitude via Eqs. (11) and (12). At each offset frequency, the drive amplitude is then swept downward from its

driven resonant frequency using the fixed drive tone, in the same

maximum value, and  $f_r$  again mapped as a function of input amplitude.

Visualizing the parameter space in this way highlights the definition of the two regimes as a function of the starting offset frequency of the drive tone. When the starting offset frequency is near to (small values of  $|f_{drive} - f_{r,0}|$ ) or above the relaxed resonant frequency  $(f_{drive} - f_{r,0} > 0)$ , the system is in the single-valued regime, where the upward and downward sweeps produce identical behavior. For initial drive frequency offsets  $f_{drive} - f_{r,0} \lesssim -50 \text{ kHz}$ , the resonance exhibits bistability. In this region, on the ascending sweep, the resonance jumps past the drive tone and the minimum attained separation between the two remains large. On the descending sweep, the resonance may be brought very close to the drive tone by reducing the drive voltage. For this resonator, at the maximum frequency offset tested, the minimum attained separation via the descending branch was ≤1% of the resonator linewidth. Any point along this branch that is sufficiently close to  $f_{drive} - f_r = 0$  may be considered to be a viable operational bias point for the resonator, in terms of sensitivity to variation in the resonator transfer function due to changing optical load.

For starting frequency offsets beyond the onset of bistability, the rate of change of the driven resonant frequency with drive voltage,  $df_r/dV_{drive}$  [Fig. 5(d)], becomes increasingly steep as  $f_r$ approaches the drive tone. Accordingly, without the ability to quickly and actively modulate the drive amplitude to compensate for them, for larger starting offsets, ever smaller fluctuations in resonator impedance (e.g., due to fluctuations in load) may destabilize the system by driving it into the runaway feedback regime and ending up in the other bistable state. This is the cause of the erratic jump points seen on the measured ascending sweeps in Fig. 7. For more modest offsets, and especially within the single-valued regime, the resonator may be operated stably at its driven frequency over a wider range of changes in incident load. The requisite stability and dynamic range, and thereby the choice of offset frequency, will depend on the operational conditions and the expected signal loading variance.

# V. CONCLUSION

We have examined the impact of readout current on the resonant frequency of kinetic inductance detectors, using a static-frequency readout drive tone. We show that the response can be understood using a simple lumped-element circuit model wherein the readout current modulates the kinetic inductance only. This model reproduces the observed changes in resonant frequency to a degree of accuracy sufficient to make it a useful predictive and interpretive tool in understanding the resonator-readout current

Varying the amplitude of a readout drive tone at fixed frequency near the resonant frequency of a target detector, we examine the response of the resonant frequency to the applied current. For small frequency offsets between the resonator at the tone, the response is single-valued: There is a unique solution for the location of the resonant frequency for a given drive amplitude, and the resonant frequency can be altered so that it exactly matches the drive frequency. This is a stable operational bias point for the resonance, and the detector may be read out at its new

At larger frequency offsets, runaway positive feedback leads to hysteretic bistability as is seen in constant-amplitude frequency sweep measurements. In this regime, in the ascending sweep, the driven resonant frequency is not accessible due to the runaway feedback, and there is therefore no stable operational point. On the descending branch, the driven resonant frequency can be relaxed by reducing the drive amplitude so that it approaches the drive tone from below. Relaxing the resonant frequency to the drive frequency in this way is analogous to the downward frequency sweep employed in Ref. 11 to operate a resonator beyond its bifurcation power. The authors of that work noted improved device noiseequivalent power when operating in this regime. While we have not investigated device responsivity and noise in this work, our observations of resonant frequency behavior as a function of readout current are consistent with theirs. The static frequency drive technique builds on their frequency-sweep analysis and allows the selection of the resonant frequency in advance, facilitating the tuning of operational bias points across an array. The ability to accurately model this behavior using a simple lumped-element circuit model is well-suited to the analysis and understanding of these effects in the context of the rest of the readout system and simplifies the development of novel readout-resonator control techniques.

We see great utility in being able to alter and control the resonant frequency of a KID in situ, without the need for specialty circuit designs or additional readout complexity. The ability to select and fine-tune resonant frequencies using a single traditional readout tone has implications for the mitigation of intermodulation distortion products and crosstalk, as well as the potential to relax fabrication complexity by correcting collisions between resonances without the need to physically trim capacitors. Recent demonstrations have shown that it is possible to actively feed back on and control the kinetic inductance during operation to keep a KID's resonant frequency fixed while the loading on it varies. 12 Such a technique requires initializing the KID to some starting drive amplitude, which sets the dynamic range of the feedback controller. This work provides a framework for the understanding and manipulation of such a system, demonstrating that the starting drive amplitude that matches the resonant frequency to the drive tone is uniquely determined by the frequency separation of the drive tone from the relaxed resonant frequency and that, via the descending branch of the amplitude sweep, a broad set of offset frequencies (and thereby wide dynamic range) are viable.

### **ACKNOWLEDGMENTS**

The authors wish to thank Peter Day for many illuminating discussions. The McGill authors acknowledge funding from the Natural Sciences and Engineering Research Council of Canada, the Canadian Foundation for Innovation, and the Canadian Institute for Advanced Research. The detectors used in this work made use of the Pritzker Nanofabrication Facility of the Institute for Molecular Engineering at the University of Chicago, which receives support from Soft and Hybrid Nanotechnology Experimental (SHyNE) Resource (NSF ECCS-2025633), a node of the National Science Foundation's National Nanotechnology Coordinated Infrastructure.

#### **AUTHOR DECLARATIONS**

### **Conflict of Interest**

The authors have no conflicts to disclose.

#### **Author Contributions**

M. Rouble: Conceptualization (lead); Formal analysis (lead); Investigation (lead); Methodology (lead); Software (equal); Visualization (lead); Writing – original draft (lead); Writing – review & editing (equal). M. Adamič: Conceptualization (supporting); Investigation (supporting); Methodology (supporting); Writing – review & editing (equal). P. S. Barry: Resources (supporting). K. R. Dibert: Resources (supporting). M. Dobbs: Conceptualization (supporting); Formal analysis (supporting); Funding acquisition (lead); Methodology (equal); Supervision (lead); Writing – review & editing (equal). K. Fichman: Resources (supporting). J. Montgomery: Conceptualization (supporting); Formal analysis (supporting); Methodology (supporting); Writing – review & editing (equal). G. Smecher: Investigation (supporting); Resources (equal); Software (equal); Writing – review & editing (equal).

### **DATA AVAILABILITY**

The data that support the findings of this study are available from the corresponding author upon reasonable request.

# APPENDIX: RESONATOR AND CIRCUIT MODEL PARAMETERS

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**TABLE I.** Resonator model parameters. To compare the model's predictions with measured resonator behavior, it is useful to use resonator impedances, which are approximately representative of the device under test.

| Symbol          | Description                          | Value                   | Units                            | Notes   |
|-----------------|--------------------------------------|-------------------------|----------------------------------|---|
| Model par       | ameters                              |                         |                                  |   |
| •               | Inductor material                    | Aluminum                |                                  |   |
| 1               | Inductor length                      | $8.33 \times 10^{-3}$   | m                                |   |
| w               | Inductor width                       | $2.00 \times 10^{-6}$   | m                                |   |
| t               | Inductor thickness                   | $3.00 \times 10^{-8}$   | m                                |   |
| $P_{opt}$       | Optical load                         | $2.50 \times 10^{-15}$  | W                                | Estimate; used to compute quasiparticle density                   |
| $T^{T}$         | Operating temperature                | 0.12                    | K                                | Used to compute quasiparticle density                             |
| $I_*$           | Nonlinear scaling current            | $1.9 \times 10^{-3}$    | A                                | Estimated as described in the text                                |
| $\Delta_0$      | Gap energy (zero-temperature)        | $1.76 \ k_B \ T_c$      | J                                | For $\Delta(T)$ , we use the numerical approximation from Ref. 16 |
| $\sigma_N$      | Normal-state conductivity            | $5.05 \times 10^{7}$    | $(\Omega \text{ m})^{-1}$        | Measured for a 30 nm Al film (T. Cecil, internal memo)            |
| $T_c$           | Critical temperature                 | 1.2                     | K                                | Estimate  |
| $N_0$           | Single-spin density of states        | $2.76 \times 10^{29}$   | $\mu {\rm m}^{-3}  {\rm J}^{-1}$ | From Refs. 2 and 25   |
| Circuit con     | nponents                             |                         |                                  |   |
| R               | Resonator real impedance             | $2.04 \times 10^{-4}$   | $\Omega$                         | From inductor geometry and complex conductivity                   |
| $L_k$           | Zero-current kinetic inductance      | $3.421 \times 10^{-9}$  | Н                                | From inductor geometry and complex conductivity                   |
| $L_{\sigma}$    | Geometric inductance                 | $7.983 \times 10^{-9}$  | Н                                | $\alpha_k = 0.3$  |
| $\frac{L_g}{C}$ | Resonator capacitance                | $1.404 \times 10^{-12}$ | F                                | From fit to measured transfer function                            |
| $C_c$           | Coupling capacitance                 | $1.77 \times 10^{-14}$  | F                                | From fit to measured transfer function                            |
| $Z_{LNA}$       | LNA input impedance                  | 50                      | $\Omega$                         |   |
| $R_1, R_2, R_3$ | Resistances in last-stage attenuator | 61.1. 247.5, 61.1       | $\Omega$                         | A 20 dB attenuator  |

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